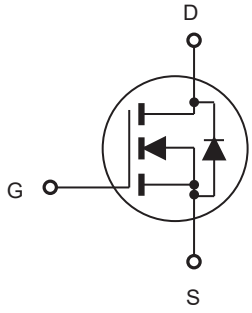
CEP1988SF/CEB1988SF
CEF1988SF

N-Channel Enhancement Mode Field Effect Transistor With Fast Body Diode

PRELIMINARY

FEATURES

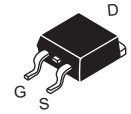
Type	V_{DSS}@$T_{J\,max}$	$R_{DS(ON)}$	I_D	@V_{GS}
CEP1988SF	900V	160mΩ	26A	10V
CEB1988SF	900V	160mΩ	26A	10V
CEF1988SF	900V	160mΩ	26A [d]	10V



- Super high dense cell design for extremely low $R_{DS(ON)}$.
- High power and current handing capability.
- Pb-free lead plating ; RoHS compliant.
- Halogen Free.
- Fast reverse recovery time.

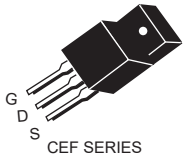
APPLICATIONS

- Adapter.
- EV Charging.
- SMPS.



CEB SERIES
TO-263(DD-PAK)

CEP SERIES
TO-220



CEF SERIES
TO-220F

ABSOLUTE MAXIMUM RATINGS T_C = 25°C unless otherwise noted

Parameter	Symbol	Limit		Units
		TO-220/263	TO-220F	
Drain-Source Voltage	V_{DS}	850		V
Gate-Source Voltage	V_{GS}	±30		V
Drain Current-Continuous @ T_C = 25℃	I_D	26	26 [d]	A
@ T_C = 100°C		16	16 [d]	A
Drain Current-Pulsed [a]	I_{DM} [e]	104	104 [d]	A
Maximum Power Dissipation @ T_C = 25°C	P_D	278	83	W
- Derate above 25°C		2.22	0.66	W/℃
Single Pulsed Avalanche Energy [g]	E_{AS}	843		mJ
Single Pulsed Avalanche Current [g]	I_{AS}	7.5		A
Operating and Store Temperature Range	T_J,T_{stg}	-55 to 150		°C

Thermal Characteristics

Parameter	Symbol	Limit		Units
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	0.45	1.5	°C/W
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	62.5	65	°C/W

Electrical Characteristics T_C = 25°C unless otherwise noted

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	V_{GS} = 0V, I_D = 250μA	850			V
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = 850V, V_{GS} = 0V			5	μA
Gate Body Leakage Current, Forward	I_{GSSF}	V_{GS} = 30V, V_{DS} = 0V			100	nA
Gate Body Leakage Current, Reverse	I_{GSSR}	V_{GS} = -30V, V_{DS} = 0V			-100	nA
On Characteristics [b]						
Gate Threshold Voltage	$V_{GS(th)}$	V_{GS} = V_{DS}, I_D = 250μA	3	4	5	V
Static Drain-Source On-Resistance	$R_{DS(on)}$	V_{GS} = 10V, I_D = 10A		137	160	mΩ
Gate Input Resistance	R_g	f=1MHz,open Drain		3.6		Ω
Dynamic Characteristics [c]						
Input Capacitance	C_{iss}	V_{DS} = 100V, V_{GS} = 0V, f = 1.0 MHz		3455		pF
Output Capacitance	C_{oss}			100		pF
Reverse Transfer Capacitance	C_{rss}			5		pF
Switching Characteristics [c]						
Turn-On Delay Time	$t_{d(on)}$	V_{DD} = 400V, I_D =2A, V_{GS} = 10V, R_{GEN} = 4.7Ω		43		ns
Turn-On Rise Time	t_r			7		ns
Turn-Off Delay Time	$t_{d(off)}$			130		ns
Turn-Off Fall Time	t_f			48		ns
Total Gate Charge	Q_g	V_{DS} = 640V,I_D = 7A, V_{GS} = 10V		70		nC
Gate-Source Charge	Q_{gs}			16		nC
Gate-Drain Charge	Q_{gd}			29		nC
Drain-Source Diode Characteristics and Maximun Ratings						
Drain-Source Diode Forward Current	I_S [f]				26	A
Drain-Source Diode Forward Voltage [b]	V_{SD}	V_{GS} = 0V, I_S = 10A			1.2	V
Reverse Recovery Time	T_{rr}	I_F = 10A,di/dt = 100A/us		176		ns
Reverse Recovery Charge	Q_{rr}			0.94		uC
Peak Reverse Recovery Current	I_{rr}			10.5		A

Notes :
a.Repetitive Rating : Pulse width limited by maximum junction temperature .
b.Pulse Test : Pulse Width ≤ 300μs, Duty Cycle ≤ 2% .
c.Guaranteed by design, not subject to production testing.
d.Limited only by maximum temperature allowed .
e.Pulse width limited by safe operating area .
f.Full package $I_{S(max)}$ = 14A .
g.L = 30mH, I_{AS} = 7.5A, V_{DD} = 50V, R_G = 25Ω, Starting T_J = 25°C.

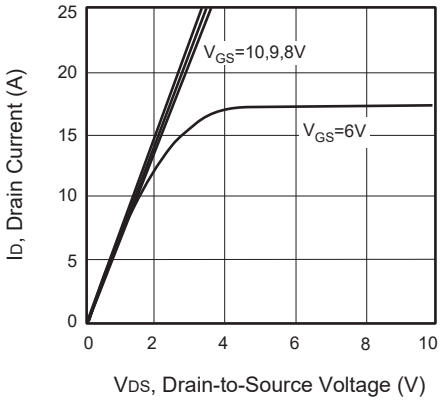


Figure 1. Output Characteristics

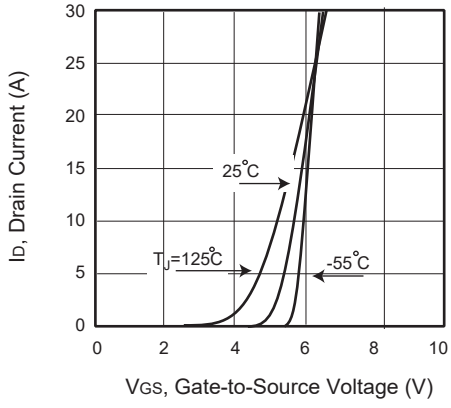


Figure 2. Transfer Characteristics

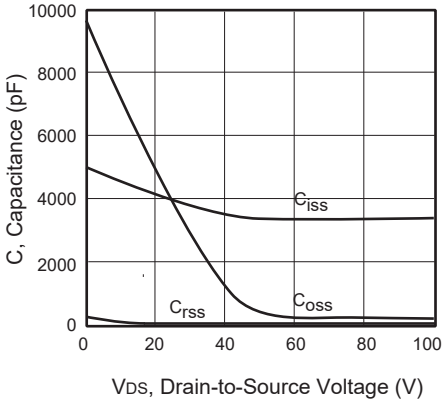


Figure 3. Capacitance

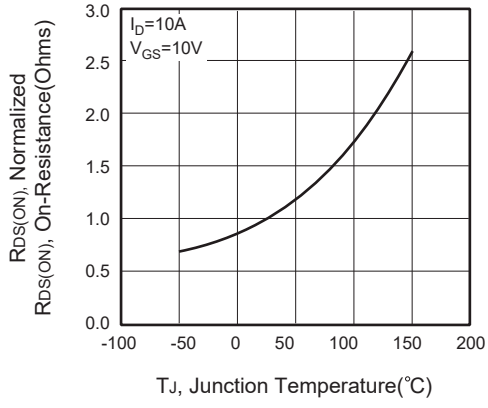


Figure 4. On-Resistance Variation with Temperature

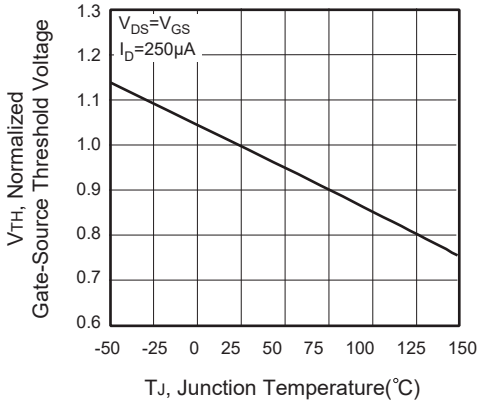


Figure 5. Gate Threshold Variation with Temperature

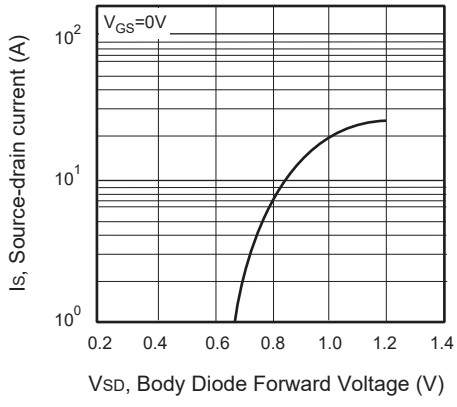


Figure 6. Body Diode Forward Voltage Variation with Source Current

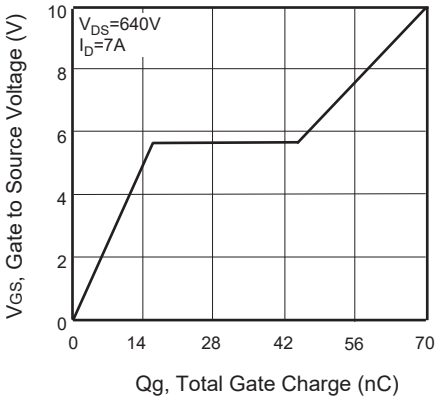


Figure 7. Gate Charge

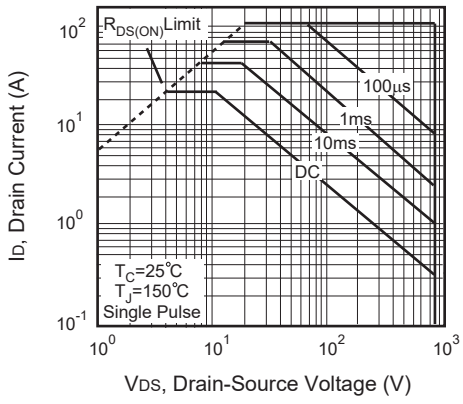


Figure 8. Maximum Safe Operating Area

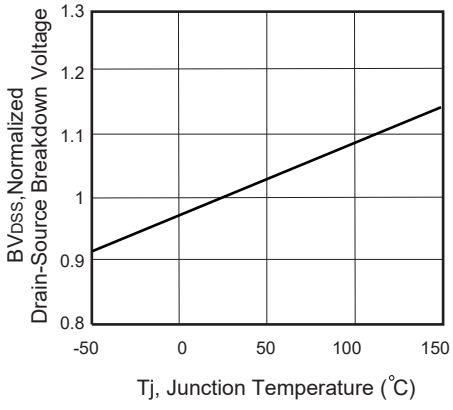


Figure 9. Breakdown Voltage Variation VS Temperature

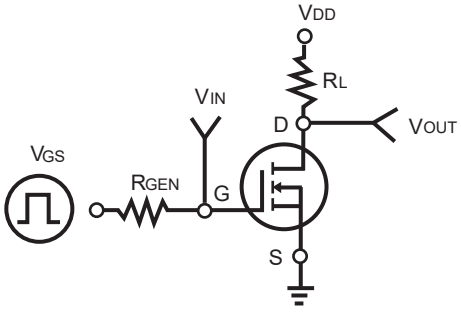


Figure 10. Switching Test Circuit

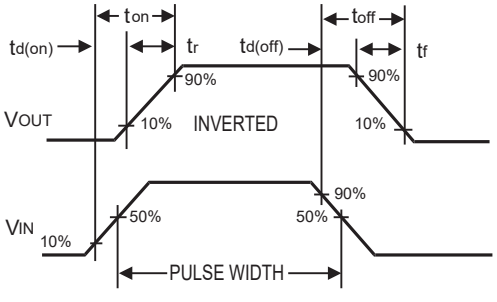


Figure 11. Switching Waveforms

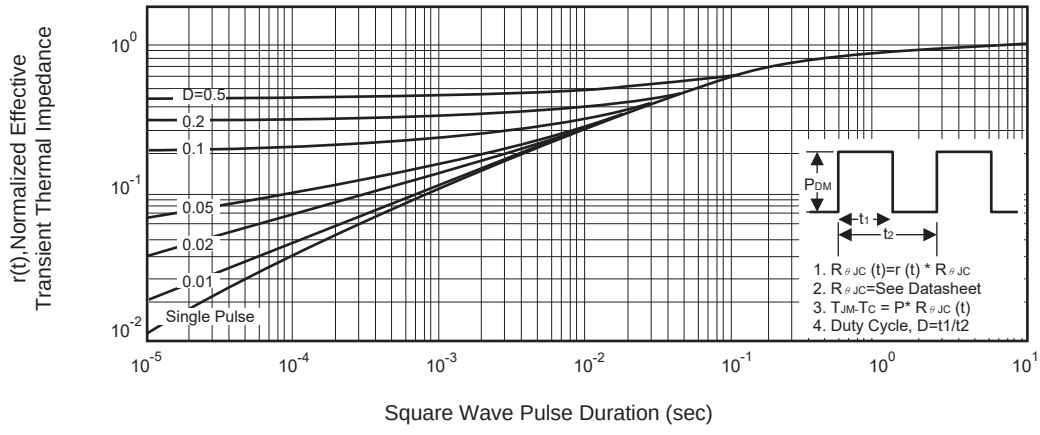


Figure 12. Normalized Thermal Transient Impedance Curve